10/582665 AP3 Rec'd PCT/PTO 13 JUN 2007

Docket No.: NIP-002

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of

Toshihisa WATANABE et al.

Confirmation No.

U.S. Patent Application No. not yet assigned

Filed: herewith

For: X-RAY DETECTION DEVICE FOR FOREIGN MATTER

## INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

In accordance with the provisions of 37 C.F.R. 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the documents listed on the attached form PTO-1449. It is respectfully requested that the documents be expressly considered during the prosecution of this application, and that the documents be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

This Information Disclosure Statement is being filed with the application and no certification or fee is required.

Each non-English language reference was cited in the corresponding International search report or discussed in the present specification. A copy of the foreign search, together with an English language version thereof, is attached for the Examiner's information.

Respectfully submitted,

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Date: June 13, 2006

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U.S. APPLICATION NO. ATTY. DOCKET NO. **NIP-002** Not yet assigned INFORMATION DISCLOSURE CITATION IN AN APPLICANT Toshihisa WATANABE et al **APPLICATION** FILING DATE **GROUP** herewith (PTO-1449) U.S. PATIENT DOGUMENTS **EXAMINER'S FILING INITIALS** PATENT NO. DATE NAME CLASS **SUBCLASS** DATE FOREIGN PATENT DOCUMENTS **EXAMINER'S** Translation PATENT NO. DATE COUNTRY CLASS SUBCLASS No INITIALS 05/09/2002 2002-131244 **JAPAN** abstract 03-057946 03/13/1991 **JAPAN** abstract 11/06/2003 2003-315286 **JAPAN** abstract 2004-125715 04/22/2004 **JAPAN** abstract OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.) **EXAMINER** DATE CONSIDERED

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.